Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/759,098	SEON ET AL.
Examiner	Art Unit
Joseph I Williams	2870

	SEAR	CHED	
Class	Subclass	Date	Examiner
313	422 495-497	11/30/2005	JW
445	23 25 50 51	11/30/2005	JW
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR)
	DATE	EXMR
see attached text search	11/30/2005	JW
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